

Search Notes

Application/Control No.

10/524,891

Examiner

CHRIS C. CHU

Applicant(s)/Patent under
Reexamination

ASSAL ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	E23.078, E23.187 & E25.016	10/13/2008	C.C.
257	720 & 713	10/13/2008	C.C.
257	675	10/13/2008	C.C.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; and IBM_TDB;	10/13/2008	C.C.